Form PTO 1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO.		SERIAL NO.		
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		RENCES CITED BY AP	Ē,	APPLICANT				
LIST OF	REFER	RENCES CITED-BY AP	PLICARU	Atsushi SADAMOTO, et al.				
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U.S. PATENT DOCUMENTS								
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			FC	REIGN PATENT DOCUMENTS				
	DOCUMENT DATE		COUNTRY		TRANSLATION YES NO			
F.K.	AO	2-78159	03/19/1990	JAPAN (with English Abstract)				×
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	AQ	2001-236979	08/31/2001	JAPAN (with English Abstract)				X
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Z.K.	AV	WO 91/19328	12/12/1991	WIPO				
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
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	ΑZ			Additional References sheet(s) attached				
Examiner ZRIE					Date Considered 1/16/2006.			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								